

Notice of References Cited

Application/Control No.

09/739,622

Applicant(s)/Patent Under

Reexamination

CASTENMILLER ET AL.

Examiner

Allen C. Ho

Art Unit

2882

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,160,622 ✓	12-2000	Dirksen et al.	356/401
	B	US-6,122,058 ✓	09-2000	Van Der Werf et al.	356/349
	C	US-6,084,673 ✓	07-2000	Van Den Brink et al.	356/358
	D	US-5,811,816 ✓	09-1998	Gallagher et al.	250/370.15
	E	US-5,801,832 ✓	09-1998	VAn Den Brink	356/358
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	I	US-5,003,342 ✓	03-1991	Nishi	355/43
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	John R. Ferraro and Kazuo Nakamoto, "INTRODUCTION RAMAN SPECTROSCOPY". Academic Press, Inc., San Diego, 1994.
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.